Searci	n Note	S

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/567,380	TANNO, ATSUSHI	
Examiner	Art Unit	
Justin R. Fischer	1791	

SEARCHED			
Class	Subclass	Date	Examiner
152	154.2		
152	155		
152	157		
152	158		
152	196		
152	197		
152	516		
152	520	10/24/2007	JRF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		·-	

SEAR (INCLUDING S	CH NOT	ES STRATEGY)
		DATE	EXMR
East text search		10/24/2007	JRF